

Notice of References Cited	Application/Control No. 10/567,126	Applicant(s)/Patent Under Reexamination CHEREPINSKY ET AL.	
	Examiner JERRY LIN	Art Unit 1631	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Cutler et al. "High-Throughput Variation Detection and Genotyping Using Microarrays," Genome Research (2001) Volume 11, pages 1913-1925.
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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